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TEST REPORT

Application No.: BTEK240509012AE

Applicant: Shenzhen Litime Technology Co., Ltd

Address of Applicant: Room 301, Building B, Baolong 5th Road, Baolong Community, Baolong

Street, Shenzhen, China.

Manufacturer: Shenzhen Litime Technology Co., Ltd

Address of Manufacturer: Room 301, Building B, Baolong 5th Road, Baolong Community, Baolong

Street, Shenzhen, China.

Equipment Under Test (EUT):

EUT Name: Litime 25.6V 50Ah Smart TM LiFePO4 Battery

Test Model.: 25.6V 50Ah Smart TM

Adding Model(s): 25.6V50Ah,25.6V50Ah Plus,25.6V50Ah Mini,25.6V50Ah Group24,25.6V50h

LTC ,25.6V 50Ah Pro,25.6V50Ah TM,25.6V 50 Ah Self-Heating,25.6V 50 Ah Max,25.6V 50Ah Smart, 25.6V 50Ah GC Smart,25.6V 50Ah Plus,25.6V 50Ah Smart Group 31,25.6V 50Ah,Group 22,25.6V 50Ah Group 24,25.6V

50Ah H190,25.6V 50Ah BT

Trade Mark: Litime

FCC ID: 2BDSV-2450

Standard(s): 47 CFR Part 2 Subpart J Section 2.1091

Date of Receipt: 2024-05-14

Date of Test: 2024-05-22 to 2024-06-10

Date of Issue: 2024-06-14

Test Result: Pass*

Lion Cai/ Approved & Authorized EMC Laboratory Manager

ShenZhen BANTEK Testing Co., Ltd.

Add: A5&A6, Building B1&B2, No.45 Gangtou Road, Bogang Community, Shajing Street

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^{*} In the configuration tested, the EUT complied with the standards specified above.



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Revision Record							
Version	Chapter	Date	Modifier	Remark			
V0		2024-06-14		Original			

Authorized for issue by		
BTEX 3	Zora. Huang	
	Zora Huang/Project Engineer	
Ō	David Throng	
	David Zhuang/Reviewer	0 0

Remarks:

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of compiler and approver.

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General Information

3.1 Details of E.U.T.

Power supply:	25.6V Battery
Frequency Range:	2402MHz to 2480MHz
Bluetooth Version:	V5.0 BLE
Modulation Type:	GFSK
Number of Channels:	40
Antenna Type:	PCB Antenna
Antenna Gain:	1.2dBi
Sample No.:	BTEK240509012AE-01

Remark: The information in this section is provided by the applicant or manufacturer, BANTEK is not liable to the accuracy, suitability, reliability or/and integrity of the information.

Model No.: 25.6V 50Ah Smart TM,25.6V50Ah,25.6V50Ah Plus,25.6V50Ah Mini,25.6V50Ah Group24,25.6V50h LTC ,25.6V 50Ah Pro,25.6V50Ah TM,25.6V 50 Ah Self-Heating,25.6V 50 Ah Max,25.6V 50Ah Smart, 25.6V 50Ah GC Smart, 25.6V 50Ah Plus, 25.6V 50Ah Smart Group 31, 25.6V 50Ah, Group 22,25.6V 50Ah Group 24,25.6V 50Ah H190,25.6V 50Ah BT

Only the model 25.6V 50Ah Smart TMI was tested. According to the declaration from the applicant, the electrical circuit design, layout, components used, internal wiring and functions of other models are identical for the above models, with only difference on Model No.

3.2 Description of Support Units

Description	Manufacturer	Model No.	Serial No.
1	32000	11 372	1

3.3 Test Location

All tests were performed at:

Shenzhen BANTEK Testing Co., Ltd.,

A5&A6, Building B1&B2, No.45 Gangtou Road, Bogang Community, Shajing Street, Bao'an District,

Shenzhen, Guangdong, China 518103

Tel:0755-2334 4200 Fax: 0755-2334 4200

FCC Registration Number: 264293 Designation Number: CN1356 No tests were sub-contracted.

3.4 Deviation from Standards

None

3.5 Abnormalities from Standard Conditions

None

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4 Test Requirement

According to §1.1307(b)(1) and KDB 447498 D01 General RF Exposure Guidance v06, system operating under the provisions of this section shall be operating in a manner that the public is not exposed to radio frequency energy level in excess limit for maximum permissible exposure.

Limits for Maximum Permissible Exposure (MPE)

Frequency range (MHz)	Electric fiel strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm²)	Averaging time (minutes)
(A) Limits for Occu	pational/Controlled	Exposures		
0.3-3.0	614	1.63	*(100)	6
3.0–30	1842/f	4.89/f	*(900/f ²)	6
30–300	61.4	0.163	1.0	6
300–1500	Bek. 3	///	f/300	6
1500–100,000	81	9	5	6
(B) Limits for Gene	eral Population/Unco	ontrolled Exposure		
0.3–1.34	614	1.63	*(100)	30
1.34–30	824/f	2.19/f	*(180/f²)	30
30–300	27.5	0.073	0.2	30
300–1500			f/1500	30
1500-100,000	C	0	1.0	30

f = frequency in MHz

Friis transmission formula: $Pd = (Pout*G)/(4*pi*r^2)$

Where

Pd = power density in mW/cm², **Pout** = output power to antenna in mW;

G = gain of antenna in linear scale, **Pi** = 3.1416;

R = distance between observation point and center of the radiator in cm

Pd id the limit of MPE, 1 mW/cm². If we know the maximum gain of the antenna and the total power input to the antenna, through the calculation, we will know the distance r where the MPE limit is reached.

4.1Assessment Result

				 	•	 •		•	_	•	••	
\boxtimes	Pa	SS	ed				No	ot	Α	pp	olica	able

Frequency (MHz)	Conducted Power (dBm)	Maximum Tune-up (dBm)	Power Density (mW/cm2)	Limit (mW/cm2)	Result
2402	2.23	2.50	0.0006	1.0000	Pass

Note: 1.The exposure evaluation safety distance is 20mm.

2. Only show the worst case in the test report.

- End of the Report -

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